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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/622,580	SUGAYA ET AL.	
Examiner	Art Unit	
Deandra M. Hughes	3663	

SEARCHED			
Class	Subclass	Date	Examiner
359	334	10/17/2005	DMH
359	341.33	10/17/2005	DMH
359	341.41	10/17/2005	DMH
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INTERFERENCE SEARCHED				
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	DATE	EXMR
East text: see attached strategy IEEE Foreign	10/17/2005	DMH
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